

**Notice of References Cited**

Application/Control No.

10/618,136

Applicant(s)/Patent Under  
Reexamination  
LAPUH ET AL.

Examiner

Xavier Szewai Wong

Art Unit

2616

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0185181 A1	10-2003	Balachandran et al.	370/337
*	B	US-2007/0198670 A1	08-2007	Andreev et al.	709/220
	C	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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